



SINGLE CRYSTAL SAPPHIRE



SINGLE CRYSTAL SAPPHIRE

Single Crystal Sapphire is playing an ever-increasingly important role as a material for, high reliablility Electronics today due to its excellent mechanical characteristics, chemical stability and light transmission.

Kyocera mass-produces Single Crystal Sapphire in a vertically integrated manner. From "pulling up" the raw material with EFG (Edge-Defined Film-Fed Growth) methods to machining, Kyocera produces and supplies various products with large diameters or specific shape requirements.

FEATURES OF EFG METHOD

Large Size Material

Sizing-up of materials allows for a broader range of applications and uses.

 Production of Single Crystal Sapphire in Any Desired Sectional Shape Since any desired sectional shape can be obtained in the form of ribbons, tubes, rods, and others, cutting processes can be eliminated, allowing for a reduction in cost.

Control of Crystal Orientation

Any axis and plane can be produced by instituting proper control during crystal growth.





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Typical Orientation

FEATURES OF SINGLE CRYSTAL SAPPHIRE

 High Strength, High Rigidity, High Anti-Abrasion, High Anti-Heat, High Anti-Corrosion Characteristics, and High Anti-Plasma Characteristics.

Because of these characteristics, Single Crystal Sapphire is widely used for precision mechanical parts.

Stable Dielectric Constant, Very Low Dielectric Loss, Good Electrical Insulation Single Crystal Sapphire is used as a material for substrates in super-high frequency regions. It is also used as an insulation material and microwave window. Single Crystal Sapphire has become indispensable in the Electronics Industries.

Excellent Light Transmission

Single Crystal Sapphire is used for various kinds of vacuum equipment, windows in reaction furnace, scanner windows and caps for optical communication due to its excellent mechanical characteristics and heat resistance.

Good Thermal Conductivity and High Heat Resistance

Excellent thermal conductivity at low temperatures allows Single Crystal Sapphire as a transparent material to be used in many diverse fields requiring thermal conduction and heat radiation.

KYOCERa

SAPPHIRE MANUFACTURING PROCESS

Sapphire Manufacturing Process

Growth of Raw Material





Lapping



Polishing

(Ra∶≦1Å) 1.00 (Y_DM_AFM 2.000 μm 1.969 V 1.485 Hz 512 NanoScope Scan size Setpoint Scan rate Number of +0 2.00 1.00 j.



*Shapes other than above are available.

As-Grown Materials





CHARACTERISTICS OF SINGLE CRYSTAL SAPPHIRE

Dielectric Constant

Characteristics of Kyocera's Single Crystal Sapphire

		Hexagonal System a=4.763Å			
	Crystallographic Structure	c=13.003Å			
tics		Rhombohedral Single crystal			
erist	Reference Density	3.97×10 ³ kg/m ³			
acte	Vickers Hardness	22.5GPa (HV1(Load=9.807N))			
Char	Flexural Strength	690MPa			
cal (Tensile Strength	2250MPa			
anio		(Diameter0.25mm Filament 25°C)			
lech	Compressive Strength	2,940MPa			
Σ	Young's Modulus	470GPa			
	Poisson's Ratio	0.18~0.29			
ics	Melting Point	2,053℃			
acteristi	Coefficient of Linear	40~400°C C parallel to Caxis 7.7×10°/°C			
	Thermal Expansion	40~400°C C perpendicular 7.0×10-6/°C			
char	Thermal Conductivity	20°C 42W/(m · k)			
al C	Specific Heat Capacity	0.75J/(g ⋅ K)			
erm	Fmittance	<0.02			
Ţ	Linitanos	$(\lambda = 2.6 \sim 3.7 \mu \mathrm{m880^\circ C})$			
S	Dielectric strength	48×10 ⁶ V/m			
istic	Volume Resistance	$20^{\circ}C$ $>10^{14}\Omega \cdot cm$			
ctdr		500℃ 10 ¹¹ Ω・cm			
ara	Dielectric Constant	C parallel to Caxis 11.5 (1MHz)			
I Ch		to Caxis 9.3 (1MHz)			
rica	Dielectric Loss Angle	<1 (×10 ⁻⁴) (1MHz)			
lect	Loss Factor	- (×10 ⁻⁴)			
ш	Dielectric Loss Tangent	10 ⁻⁴ max.			
eristics	Index of Reflection	No=1.768			
l Charact		Ne=1.760 @589nm			
Optical	Optical Transmission	Refer to Fig.5			

C AXI 40 CA Thermal Couductivity (W/m·K) 30 20 10 0 -100 100 300 500 700 900 1100 1300 1500 1700 300 500 700 900 1100 1300 1500 1700 100 Temperature(°C) Temperature(°C) Fig. 1 Thermal Expansion vs. Temperature Fig. 2 Thermal Conductivity vs. Temperature 16.0 15.0 14.0 0.003 13.0 parallel to tan**Q** 12.0 11.0 Perpeudiculat to C Axis 10.0 0.001 9.0 8.0 0 1300 100 300 500 700 900 1100 10² 10³ 104 105 106 107 108 109 1010 Temperature(°C) Frequency(Hz) Fig. 3 Dielectric Constant vs. Temperature Fig. 4 Dielectric Loss vs. Frequency 100 80 External Transmission(%) 60 40 20 0 0.1 0.15 0.2 0.3 0.4 0.5 0.6 0.8 1.0 1.5 2.0 3.0 4.0 5.0 6.0 Wave Length(µm) Fig. 5 Transmission vs. Wave Length NOTE: •Transmittance range varies depending on thickness of Sapphire Products.

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•Interfacial Reflection included

•Thickness 1mm.

*Each Crystal Orientation has different characteristics.

*These figures are representative.

Standard Dimensional Tolerance							
Nominal Dimension : a	1>a	1≦a≦4	4 <a≦25< th=""><th>25<a≦102< th=""><th>102<a≦190< th=""><th>190<a< th=""></a<></th></a≦190<></th></a≦102<></th></a≦25<>	25 <a≦102< th=""><th>102<a≦190< th=""><th>190<a< th=""></a<></th></a≦190<></th></a≦102<>	102 <a≦190< th=""><th>190<a< th=""></a<></th></a≦190<>	190 <a< th=""></a<>	
$\begin{array}{c} \text{Tolerance} \\ (\pm) \end{array}$	0.05	0.1	0.2	0.25	0.5	1	

Machining accuracy: Tube 1.A.10.A.and standard tube thickness tolerance…±0.25. Hole diameter and standard pitch tolerance $\cdots \pm 0.1$

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SAPPHIRE PRODUCTS

Substrate



Application

(1)High Brightness LED
(2)HB-LED Semiconductor, Piezoelectric Semiconductor, Superconductor, Thin Film Substrate.
(3)MR Sensor, Precision Resistor

(4)Optical Devices

(5)Thin Film HIC

- Single Crystal Sapphire is widely used substrate material for blue, green, ultraviolet and white LEDs. It has excellent features as a base substrate for GaN deposition and great mass-productivity. In addition, it can meet future larger-size demand.
- Single Crystal Sapphire is used as a base substrate in thin film deposition because of its lattice alignment match with a variety of semiconductor materials combined with excellent thermal and chemical stability.



Standard Dimension and Tolerance

	Size	O.F. Length	
8″	$\phi 200 \pm 0.25 \times 0.725 \pm 0.05$	55~60	
6″	$\phi 150 \pm 0.25 \times 0.625 \pm 0.05$	45~50	
5″	$\phi 125 \pm 0.25 \times 0.625 \pm 0.05$	40~45	
4″	$\phi 100 \pm 0.25 \times 0.53 \pm 0.05$	30~35	
3″	$\phi76.2\pm0.25\times0.43\pm0.05$	19~25	
2″	$\phi 50.8 \pm 0.25 \times 0.33 \pm 0.05$	13~19	

Specifications other than above are available.
 Available sizes are dependent on a crystal orientation.
 Sizes and tolerances other than the above table are also available under customer requirements. Please contact or send your requirements to Kyocera.

Application Examples





Semiconductor Process Equipment Parts



Application

- (1)Carrier Plate
 (2)Microwave Entrance Tube
 (3)Dummy Water
 (4)Handling Arm
 (5)Vacuum Chuck
 (6)Window
- It is used as various Semiconductor Process Equipment due to its high anti-plasma and high anti-heat characteristics.









(3)



Optical Products for LCD Projectors



Application

- (1) Sapphire Plate
 - Polarizing Film Attached
 - Holder Assembled
 - Dichroic Filter
- (2) LCD Projector Dust Control Plate
- Sapphire material realizes high brightness and high picture quality for LCD projectors due to its high thermal conductivity and optical properties.
- Coating such as Dichroic Filter, to prevent reflection features is available.
- Standard sizes to fit in various LCD panels are available.

JP Patent No. 3091183, No.3443549 U.S. Patent No. 6577375, No.6642989

Selected Transmission Layer for Wave Length Optical Transmission



AR Coat External Transmission



*Characteristic values are subjected to change due to each specs or conditions.

Optical Products



Application

 (1)POS Scanner Window (SOG)
 (2)Window
 (3)Cap for Optical Communication
 (4)Infrared Measuring Device Window
 (5)Coin Sensor

(6)Lamp External Tube High Pressure Sodium, Xenon, Ultra Pressure mercury Metallic Halide (7)Light Receiving Window Accelerating Tube

Others



Application

 (1)Fiber Bar Guide
 (2)Insulating Plate and Rod
 (3)Single Crystal Material Sheel Holder
 (4)Biomaterial (BIOCERAM[®])
 (5)Watch Window
 (6)NMR Protection Tube

(7)Thermocouple Protection Tube (8)HDC Resonator Rod

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https://global.kyocera.com/prdct/fc/

Kyocera Fine Ceramics



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Product Inquiries→